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(consistency point* or check point* or
checkpoint* or check-point*) and leak*

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Help

(consistency point* or check point* or
checkpoint* or check-point*) and garbage
collect*

#2 17 hits

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ACM Search

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1 hits

+abstract:check +abstract:point* +abstract:garbage

+abstract:collect* ... 11 hits

+consistency +point* +garbage +collect* ... 1 hit



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